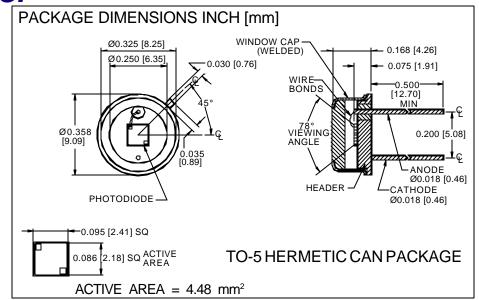
# **PHOTONIC** Silicon Photodiode, U.V. Enhanced Photoconductive **DETECTORS INC.** Type PDU-C105





#### **FEATURES**

- High speed
- U.V. enhanced
- Low capacitance
- U.V. window

### **DESCRIPTION**

The **PDU-C105** is a silicon, PIN planar diffused, U.V. enhanced photodiode. Ideal for high speed photoconductive applications. Packaged in a hermetic TO-5 metal can with a U.V. transmitting window.

## **APPLICATIONS**

- Spectrometers
- Fluorescent analysers
- U.V. meters
- Colorimeters

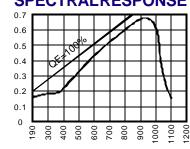
RESPONSIVITY (A/W)

## ABSOLUTE MAXIMUM RATING (TA=25°C unless otherwise noted)

SYMBOL	PARAMETER	MIN	MAX	UNITS	
VBR	Reverse Voltage		30	V	
T <sub>STG</sub>	Storage Temperature	-55	+150	⊙C	
То	Operating Temperature Range	-40	+125	∘C	
Ts	Soldering Temperature*		+240	∘C	
I <sub>L</sub>	Light Current		500	mA	

<sup>\*1/16</sup> inch from case for 3 secs max

#### **SPECTRALRESPONSE**



WAVELENGTH(nm)

## ELECTRO-OPTICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

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SYMBOL	CHARACTERISTIC	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Isc	Short Circuit Current	H = 100 fc, 2850 K	40	56		μΑ
ΙD	Dark Current	$H = 0, V_R = 5 V$		1.0	5.0	nA
RsH	Shunt Resistance	$H = 0, V_R = 10 \text{ mV}$	.25	1.0		GΩ
TC Rsh	RSH Temp. Coefficient	$H = 0, V_R = 10 \text{ mV}$		-8		%/℃
C	Junction Capacitance	$H = 0, V_R = 5 V^{**}$		37		рF
λrange	Spectral Application Range	Spot Scan	190		1100	nm
R	Responsivity	$V_{R} = 0 \text{ V}, \lambda = 254 \text{ nm}$	.12	.18		A/W
V <sub>BR</sub>	Breakdown Voltage	Ι = 10 μΑ	15	25		V
NEP	Noise Equivalent Power	V <sub>R</sub> = 10 mV @ Peak		1.3x10 <sup>-14</sup>		W/√Hz
tr	Response Time	$RL = 1 K\Omega V_{p} = 5 V$		50		nS

Information in this technical data sheet is believed to be correct and reliable. However, no responsibility is assumed for possible inaccuracies or omission. Specifications are subject to change without notice.\*\*f=1 MHz